Page 1 (No. of Pages 3)

VALVE ELECTRONIC

HINISTRY OF SUPPLY - DLRD/RRE

Specification M.O.S. CVL036	SEC	SECURITY				
Issue 2 Dated 6 Nov. 1956	Specification	Yalve				
To be read in conjunction with K1001, BS448 & BS1409	UNCLASSIFIED	UNCLASSIFIED				

Indicates a Change

Description of the Committee of Charles and the Committee of the Committee							
TYPE OF VALVE - Reliable Half-wave Rectifier with Flexible	MARKINO						
CATHODE - Indirectly-heated		See K1001/4					
ENVELOPE - Glass							
PROTOTYPE - CV2235							
RATING All limiting values are absolute					BAS	E	
		_	te		B9A/	ne .	
Heater Voltage	(A)	6.3	В				
Max. Peak Inverse Voltage	(kV)	1.8					
Max. Peak Anode Current Max. Heater-Cathode Voltage	(mA) (V)	900 650		CONNECTIONS			
Max. Bulb Temperature Max. Altitude for full PIV rating	(°C)	220 60,000	B	Lead		Elec	trode
Max. Shock (short duration)	(g)	500	0	-			
Max. Acceleration (continuous vibration)	(g)	2.5		1 2			nnected nnected
Typical Operation with Condenser Input Filter				3	Cathode		intecced
1. At 500V rms Max. (Note C)				4	Heater		
Max Mean Anode Current	(mA)	300		5	Heater Interna	117 60	nnaat ad
Min. Limiting Resistance per valve	(ohms)	300	1	7	Interns		
Max. Reservoir Condenser	(μF)	16		8	Interna		
2. At 625V rms Max. (Note D)		9		9		lly co	nnested
			l	TC	Anode		
Max. Mean Anode Current Min. Limiting Resistance per valve	(mA) obses)	250 500			#in	CAR	
Max. Reservoir Condenser	14.)	16	1	See K1001/AI/D5.2 with			
					lead 32		
					DIME	ENOI ENE	
				See K1001/AI/D11			5
				Dimensi	ons (mm)	Min.	Max.
				A		66.5	76
			1	В		19	22,2
				D		38	-
				MCUNTING POSITI			
						Any	

NOTES

- 5. Caution to Electronic Equipment Design Engineers: Special attention should be given to the working temperature of a valve operating in an airborne equipment. Reliability will be seriously impaired if the maximum bulb temperature is exceeded. The life expectancy may be reduced if conditions other than those specified for Life Test are imposed on the valve and will be reduced appreciably if absolute maximum ratings are exceeded. Both reliability and performance will be jeopardised if the heater voltage rating is exceeded; life and performance reliability are directly related to the degree that the regulation of the heater voltage is maintained at its centre-rated value.
- C. Two valves operating in a full-wave circuit. Input Voltage = 500 0 500V rms.
- D. Two walves operating in a full-wave circuit. Input Voltage = 625 0 625V rms.

To be performed in addition to those applicable in K1001 Tests shall be performed in the specified order unless otherwise agreed with the Inspecting Authority

Test Conditions - unless otherwise specified RL (V) 6.3 (Vrms) (Ohms) (pF) 8 Note 1 625 5000 Limits AQL Insp. Sym K1001 Test Test Conditions Units 8 Level bol Min. LAL Bogey UAL Max. ALD Class Strain 7.1 No voltages 6.5 1 GROUP A Voltage Breakdown 100% Combined AQL Group B 1.0 Heater Current 0.65 0.9 Ih H-K Leakage Current Vhk = 330V Note 6 0.65 II Ihk 150 ALL V Anode Voltage 18 Set Ia = 150mA DC 0.65 26 Output Current 0.65 II 120 Ide mA GROUP C Hot Switch Note 3 Lead Fragility Output Current 5.12 6.5 No Voltages Va = 500V rms Note 4 IA Ide 145 mA Hot Switch Supply frequency = 1.5 6.5 IA to 2.4 kcs Notes 3 & 7 Combined AQL GROUP D 6.5 11.3 Fatigue Vh = 7.0V switched IA 1 min. on and 3 mins off Va = 0 Frequency = 170 c/s; Min. peak Acceleration Duration = 30,39,30 hrs. Post Fatigue Tests H-K Leakage Current Voltage Breakdown Vhk = 330V Note 6 Note 2 2.5 2.5 2.5 Ihk 200 DA Output Current 120 Idc 11.4 Hammer angle = 30° Shock IA No voltages Post-Shock Tests 2.5 2.5 2.5 H-K Leakage Current Voltage Breakdown Vhk = 330V Note 6 Ihk 200 M Note 2 Output Current Ido 120 mA

CV4036/2/2

Z.14233.R.

K1001	Test	Test Conditions	AQL 5	Insp.		Limits						Units
						Min.	LAL	Bogey	UAL	Haz.	ALD	
A VI/ 5	GROUP E Life	Va = 500V rms 150 Vhk = V out + 350 V rms C = 8 uF Note 5										
A VI/ 5.1	Stability Life Test Change in Anode Voltage	Set 1a = 150 mA	1.0	I	Д ∀а	-	-	-	-	10		%
A VI/ 5.3	Intermittent Life Test	As above		IA								
	Life Test End-point (500 hours)	Combined AQL	6.5									
A VI/ 5.6	Inoperatives Heater Current H-K Leakage Current Output Current	Vhk = 330V Note 6	2.5 2.5 2.5 4.0		Ih Ihk Ide	0.9	=	:	:	1.4 150		A 114
	Life Test End-point (1000 hours)	Combined AQL	10.0									
A VI/ 5.6	Inoperatives Heater Current H-K Leakage Current Output Current	Vhk = 330V Note 6	4.0 4.0 4.0 6.5		Ih Ihk Ide	0.9	-	-	:	1.4		A JIA MA
AIX/ 2.5	Group F Electrical re-test after 28 days holding Period			100%								
AVI/ 5.6	Inoperatives		0.5									

NOTES

- 1. Measured in a 50 c/s half-wave circuit, Initially, the total supply impedance (including transformer) shall be adjusted, so that a valve giving an output current of 150 mA DC for a voltage drop across the valve of 22V DC, will give an output current of 125 mA with an anode load resistance of 5k and a reservoir condenser of 8 µF. The heater-cathode voltage shall be the output voltage. The anode voltage shall be measured directly from anode to earth using a normal rectifier meter.
- 2. The valve shall be cold when inserted into the test socket. Alternatively, it may be inserted into a preheating panel and operated under conditions similar to those obtaining in Note 1, with the output voltage appearing between heater and cathode. Valves shall be rejected which spark, flash more than once, or show heater-cathode breakdown initially or when fully heated.
- 3. Arcing within the valve shall be cause for rejection when the anode voltage is switched on and off six times. This test may be combined with the voltage breakdown test in Group A.
- 4. As for Note 1, except that the output current shall be 150 mA with a load resistor of 3k.
- 5. The Life test circuit shall be adjusted so that, using a load resistor of 3k (approx) and a reservoir capacitor of 8 mF (approx), an output current of 150 mA is obtained with a peak current greater than 900 mA but not more than 14.
- 6. Measured with cathode positive with respect to heater and with a series resistor of $330k_{\bullet}$
- 7. As for Mote 1, but with the reservoir condenser adjusted to suit the test frequency. Test at any convenient frequency within the range 1.5 to 2.4 kc/s.